Claims

What is claimed is:

[c1] A method of making fused silica, comprising: generating a plasma; delivering reactants comprising a silica precursor into the plasma to produce silica particles; and

depositing the silica particles on a deposition surface to form glass.

- [c2] The method of claim 1, wherein delivering reactants comprising a silical precursor into the flame further comprises delivering a dopant material into the plasma to form doped silica particles.
- [c3] The method of claim 2, wherein the dopant material comprises a compound capable of being converted to an oxide of at least one member of the group consisting of B, Al, Ge, K, Ca, Sn, Ti, P, Se, Er, and S.
- [c4] The method of claim 2, wherein the dopant material comprises a fluorine compound.
- [c5] The method of claim 4, wherein the fluorine compound is selected from the group consisting of CF₄, CF_xCl_{4-x}, where x ranges from 1 to 3, NF₃, SF₆, SiF₄, C₂F₆, and F₂.
- [e6] The method of claim 1, wherein the plasma is generated by induction with a high frequency generator.
- [c7] The method of claim 1, wherein the silica precursor is substantially free of hydrogen.
- [c8] The method of claim 7, wherein the silica precursor comprises SiCl₄.

- [c9] The method of claim 1, wherein the glass is formed in an enclosure having a water vapor content less than 1 ppm by volume.
- [c10] A method of making fluorine-doped glass, comprising: generating a plasma;
 - delivering reactants comprising a silica precursor and a fluorine compound into the plasma to form fluorine-doped silica particles; and
 - depositing the fluorine-doped silica particles on a deposition surface to form glass.
- [c11] The method of claim 10, wherein the silica precursor and fluorine compound are delivered into the plasma in gaseous form.
- [c12] The method of claim 10, wherein the silica precursor is substantially free of hydrogen.
- [c13] The method of claim 12, wherein the silica precursor comprises SiCl₄.
- [c14] The method of claim 10, wherein the fluorine compound is selected from the group consisting of CF₄, CF_xCl_{4-x}, where x ranges from 1 to 3, NF₃, SF₆, SiF₄, C₂F₆, and F₂.
- [c15] The method of claim 10, wherein the glass is formed in an enclosure having a water vapor content less than 1 ppm by volume.
- [c16] A photomask material produced by a method comprising: generating a plasma;
 - delivering reactants comprising a silica precursor into the plasma to form silica particles; and
 - depositing the silica particles on a deposition surface to form glass.
- [c17] The photomask material of claim 16, wherein the silica precursor is substantially free of hydrogen.
- [c18] The photomask material of claim 17, wherein the silica precursor comprises SiCl₄.

- [c19] The photomask material of claim 16, wherein the glass is formed in an enclosure having a water vapor content less than 1 ppm by volume.
- [c20] The photomask material of claim 16, further comprising delivering a dopant material into the plasma to form doped silica particles.
- [e21] The photomask material of claim 20, wherein the dopant material comprises a fluorine compound.
- [c22] The photomask material of claim 21, wherein the fluorine compound is selected from the group consisting of CF₄, CF_xCl_{4-x}, where x ranges from 1 to 3, NF₃, SF₆, SiF₄, C₂F₆, and F₂.
- [c23] A photomask for use at 157-nm comprising a silica glass made by plasma induction.